

Search Notes

Application/Control No.

10/553,452

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under
Reexamination

LE CREFF ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	211.02 199 200	4/12/07	QN
370	522	4/12/07	QN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
379	211.02 199 200	8/14/07	QN
370	522	8/14/07	QN
Interference searched history printout		8/14/07	QN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched: East, USPGPub, USPAT, JPO,EPO	4/12/07	QN
Inventor searched in PALM database	4/12/07	QN